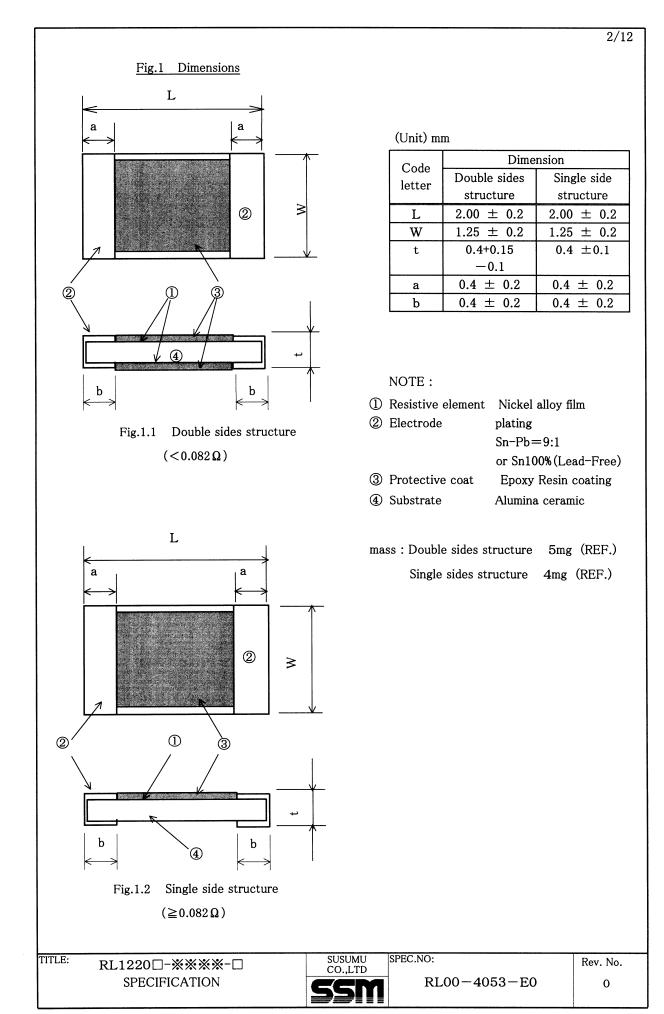
1. Scope

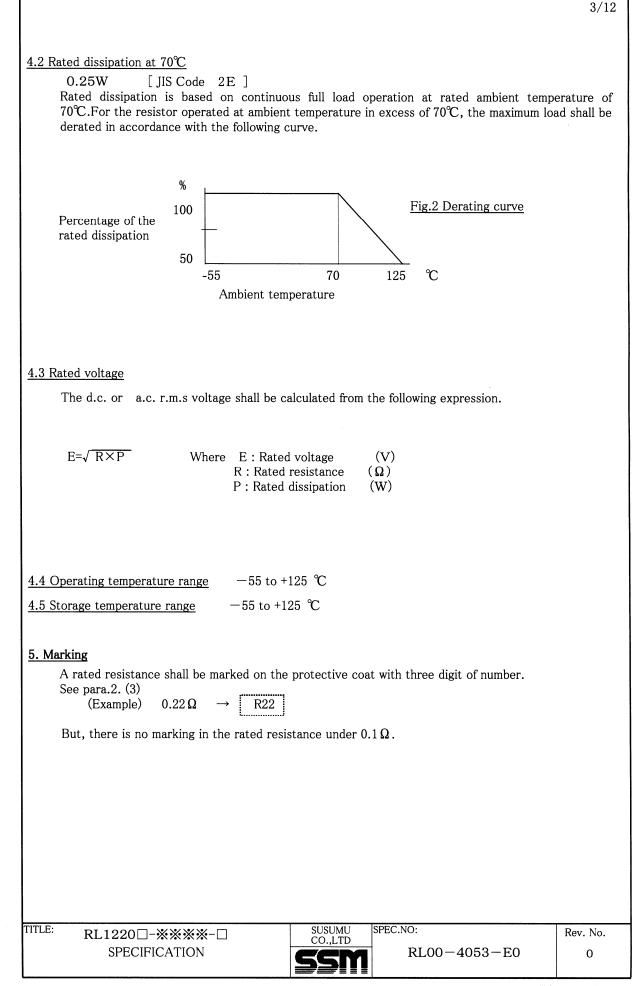
This specification applies to 1. 25×2.00 mm , 0. 25W fixed metal film low resistance value chip resistors rectangular type.

2. Type Designation

		<u>RL</u> 122	<u>20 </u>	- 🗆	
		(1) (2)	(3) (4)	(5)	
		(1)Product Typ	0e		
		RL : Fix	xed metal film low resistanc	e value chip resistors recta	ngular type
		(2) Size			
			1.25×2.00 mm		
		(3) Temperature	coefficient of resistance		
		S: 0∼	+200 ppm/°C		
		T: 0∼	~+350ppm/°C		
		(4) Rated resista	ance		
		E-12 serie	es Three digits of nu Four digits of nu	mber Example R10= mber R022	$= 0.1 \Omega$ $= 0.022 \Omega$
		(5) Tolerance or	n rated resistance		
		F :	$\pm 1.0\%$		
		G :	$\pm 2.0\%$		
		J : =	$\pm 5.0\%$		
<u>3.</u>	Phys	ical Dimensions			
	See F	Fig.1.			
4.	Ratir	ıgs			
			erance on rated resistance	and Temperature coeffic	ient of resistance
	(1)	Rated resistance E-12 series	0.010 Ω ~0.018 Ω	$0.022\Omega \sim 0.082\Omega$	0.1Ω~10Ω
	(2)	Tolerance on rated resistance	±5.0%(Code:J)	$\pm 2.0\%$ (Code:G) $\pm 5.0\%$ (Code:J)	$\pm 1.0\%$ (Code:F) $\pm 2.0\%$ (Code:G)
	(3)	Temperature coefficient of resistance		0 ppm/℃ de:T)	0∼+200 ppm/°C (Code:S)
			/ / APPD	1.0 20000	UMU CO.,LTD
			/// 24/ /// CHKD	H.Tanaka SPI	20□- ※※※※ -□ ECIFICATION
			/ / 24 / DRAW	Aug/2001 Y.Chou SPEC.NO:	
				ug/2001	
0 REV		edition. IANG.NO NOTE.	DATE DRAWN APPD	5M RLO	00 - 4053 - E0
	1 0.1				



Downloaded from Datasheet.su



6. Performance

The test method shall be as specified in IEC 60115-1. Standard atmospheric conditions

Unless otherwise specified, the standard range of atmospheric conditions for making measurements tests is as follows;

Temperature	5 to 35°C
Relative humidity	45 to 85%RH
Air pressure	86 to 106kPa
If there is any doubt about r	esults, measurements shall be made within the following limits;
Temperature	20 ± 2 °C

Relative humidity	60 to 70%RH
Air pressure	86 to 106kPa

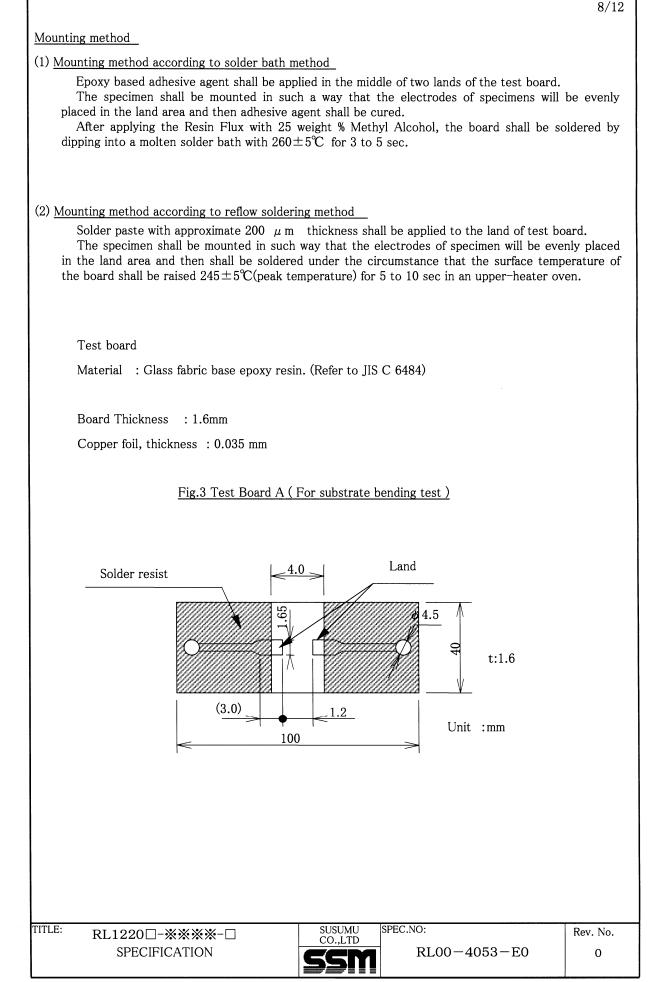
Table.	1	Performance

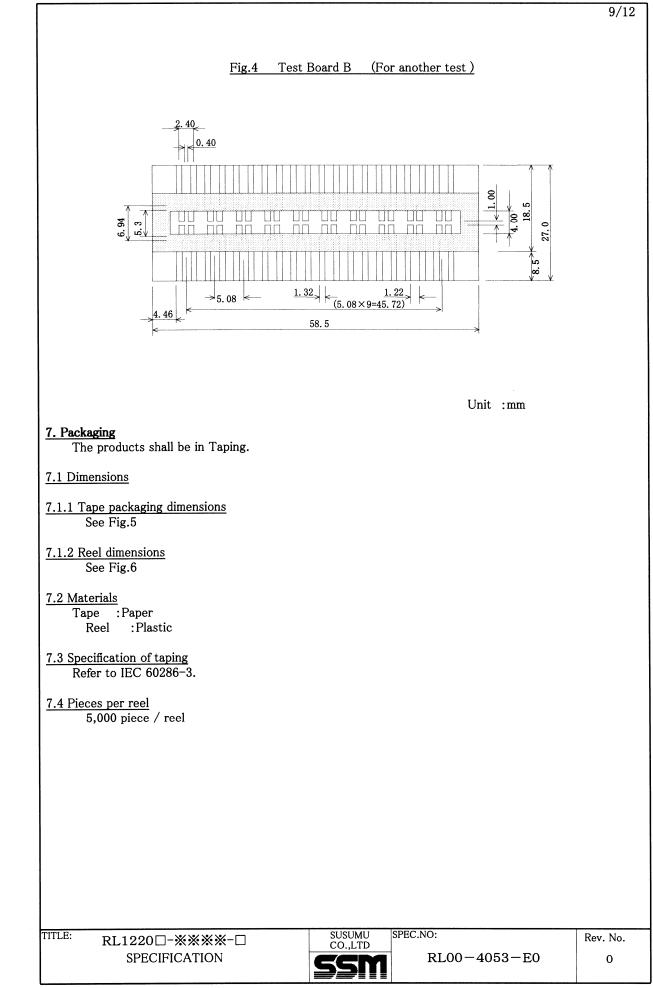
	Item	Conditions	Specifications
1	Resistance and tolerance	Refer to IEC 60115-1, Sub-clause 4.5.	Not exceed the specifie tolerance on rated resistance in para.4.1 (2).
2	Temperature characteristic of resistance	Resistance shall be measured under standard atmospheric conditions. When the temperature reaches and is maintained at 100°C higher than the temperature of standard atmospheric conditions, resistance shall be measured again. The measurement shall be made after a period of 30 min, after each specified temperature is reached. Refer to IEC 60115-1, Sub-clause 4.13.	Not exceed the specifie temperature coefficien of resistance in para.4.1. (3).
3	Overload	A d.c. or a.c. r.m.s. voltage of 2.5 times the rated voltage shall be applied for 5 sec, and a check shall be made to see if arcing or other damage happened. Then the specimen shall be maintained without electrical load for 30 min after which the resistance shall be measured. However the applied voltage shall not exceed the maximum overload voltage. Refer to IEC 60115-1, Sub-clause 4.13.	Change in resistance \pm (0.5%) Without damage by flas over (spark, arcing burning or breakdow etc.
TLE:	 RL1220□-※※	×××−□ SUSUMU SPEC.NO:	Rev. No.

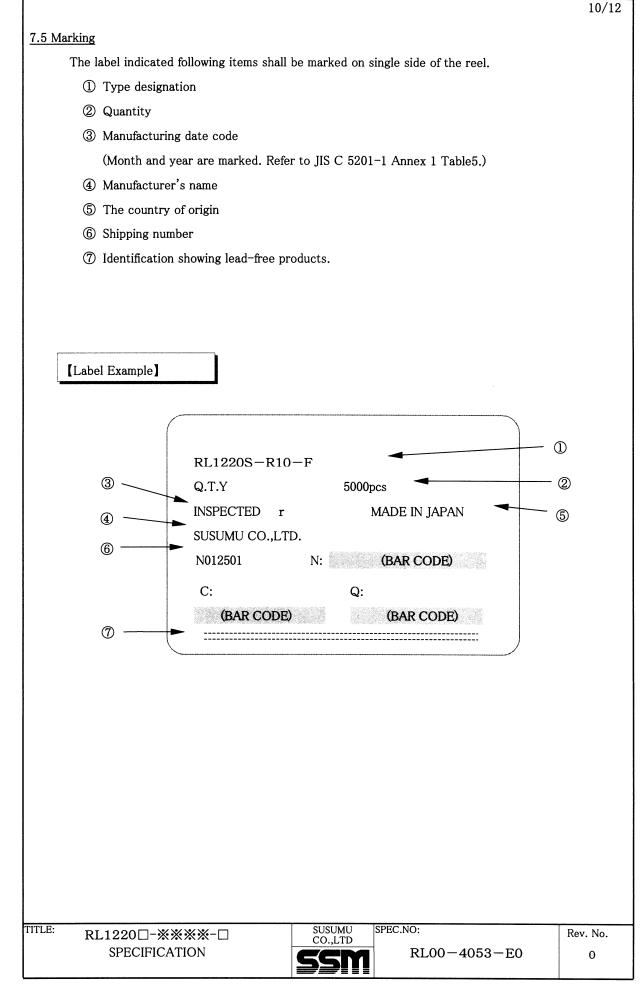
No	Item	Table. 1 Performance (Continued) Conditions	Specifications
4	Insulation	Place the specimen on the groove of metal plate	(1)Between electrodes and
4	resistance	so that the edge of metal block positions almost	insulating enclosure. 100M
	resistance	center of both electrodes, with the surface of	Ω or more
		insulation enclosure located downward or upward	(2)Between electrodes
		and pressurize the block by a force of 1.0 ± 0.2 N.	and base material.
		The test voltage shall be $100 \pm 15 \text{ Vd.c.}$, and	1000M Ω or more
		maintain this voltage for about 1 min. The	
		insulation resistance shall then be measured while	
		applying the voltage.	
	Measurem	ent point A on metallic block Insulation plate	
	RO	25mm~R0.5mm	B on metallic plate
	Insula	tion plate / Pressure by spring	
	Insulating e	nclosure surface	
		Specimen	
	Valtara ana f	Refer to IEC 60115-1,Sub-clause 4.6.	Change in resistance
5	Voltage proof	The specimen shall be tested as shown in paragraph 6.1.4.	Change in resistance $\pm (0.5\%)$
		The test voltage shall be a voltage of 100V (a.c.	Without damage by flas
		r.m.s.) between both electrode.	over (spark, arcing)
		The voltage is gradually increased at a rate of	
		about 100 V/s. from almost 0 V to the specified	•
		voltage and maintained as it is for 60s. ± 5 s., then	
		gradually decreased to almost 0 V.	
		Refer to IEC 60115-1, Sub-clause 4.7.	
6	Substrate	Apply pressure in the direction of the arrow at a	-
	bending test	rate of about 1mm/s. until bent width reaches 3	
	(Bond strength	mm and hold for 30 s.	Without mechanical
	of the face	Testing board A Specimen	damage such as breaks.
	plating)		
		Support	
		Solder	
		(\$ 5)	
		45 45	
		4.5 4.5	
LE:	RL1220□->	XXXX −□ SUSUMU SPEC.NO: CO.,LTD	Rev. No

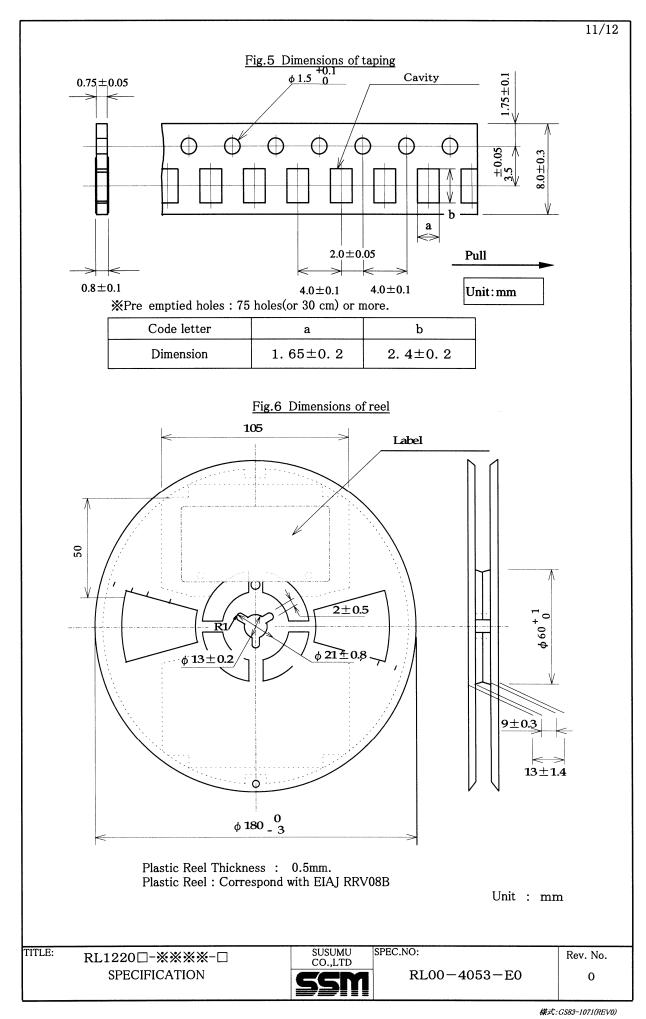
		Table. 1 Performance (Continued)	
No	Item	Specifications	
6	Substrate bending test (Bond strength of the face plating) (Continued)	Pressure tool R230 Refer to IEC 60115-1, Sub-clause 4.33.	
7	Body strength	A load of 10 N {1.02kgf} using a R0.5 pressure rod shall be applied to the center in the direction of arrow and held for 10 ± 1 sec. Loading R0.5 Specimen	Change in Resistance : ±(0.5%) Without mechanical damage such as breaks.
soldering heat		 (1) Solder bath method Pre-heat : 100 to 110℃ 30 sec. Temperature : 270±5℃ 10±1 sec. (2) Reflow soldering method Peak temperature : 260±5℃ 10 sec. or less Temperature : 220±5℃ 60 sec. max. 2 cycles or less The temperature shall be board surface temperature. (3) Soldering iron method Bit Temperature : 350±5℃ Time 時間 : 3+1/Osec The specimen shall be stored at standard atmospheric conditions for 1 hr after which the measurements shall be made. Refer to IEC 60115-1, Sub-clause 4.18. 	Change in Resistance : ±(0.5% Without mechanic damage. Electrical characteristics sha be satisfied.
		Refer to IEC 60115-1, Sub-clause 4.18.	<u></u>

No	Item		Conditions	;	Specifications		
9	Solderability	Solder	Solder temperature : 235±5℃		A new uniform coating of		
			on of immersion : 2±	solder shall cover a			
		Sn-Pb	solder		minimum of 95% of the		
		Refer t	o IEC 60115-1, Sub-cl	ause 4.17.	surface being		
		Solder	temperature : 245±5	5°C	immersed.		
		Duratio	on of immersion $:2\pm$	0. 5sec			
			g–0.5Cu solder				
			o IEC 60115-1, Sub-cl	ause 4.17.			
10	Solvent		ion cleaning		Without distinct		
	Resistance	At nor	nal temperature, 5min	damage in appearance.			
		Rofor t	o IEC 60115-1, Sub-cl				
11	Rapid change		ecimen shall be subject		Change in resistance :		
	of temperature	-	each as shown in the f		$\pm (0.5\%)$		
	· · · · · · · · · · · · · · · · · · ·	-,,			Without mechanical		
			Temperature	Time	damage and distinct		
		1		30min	damage in appearance.		
		2	R.T	$2\sim3$ min			
		3	$+125\pm2$ °C	30min			
		4	R.T	2~3min			
		Use for Testing board B.		-			
		R.T. =	Room Temperature				
		Refer t	o IEC 60115-1, Sub-cl				
12	Endurance	The sp	ecimen shall be placed	in the test chamber	Change in resistance :		
	(Damp heat	at a	temperature 60 ± 2 °	$\pm(1.0\%)$			
	with load)	1	ty 90 to 95 %, and t				
			cycle consisting of	-			
			tion of 1 hr 30 min	damage in appearance.			
			edly for $1000 + 48/0$ hrs				
			er the applied voltage element voltage.				
		linnea	element voltage.				
13	Endurance	The sp	ecimen shall be placed	in the test chamber	· Change in resistance :		
	(Rated load)	-	$\pm 2^{\circ}$ C, and then subj	-			
		cycle o	consisting of rated d.c.	voltage application	Without mechanical		
			\cdot 30 min and rest of 30	damage and distinc damage in appearance.			
			48/0 hrs.				
			er the applied voltage	shall not exceed the	•		
			element voltage.				
			ther procedures, refer	to IEC 60115-1,			
		Sub-cl					
		Refer to IEC 60115-1, Sub-clause 4.25.					
	•						
LE:				JMU SPEC.NO:	Rev. 1		









8. Precautions in use

8.1 Storage

(1)The product shall be stored in a room where temperature and humidity must be controlled.

(temperature 5 to 35 $\,^{\circ}\!\mathrm{C}$, humidity 45 to 85 % RH)

- However, humidity keeps it low, as it is possible.
- (2)The product shall be stored as direct sunshine doesn't hit on it.
- (3)The product shall be stored with no moisture, dust, a material that will make solderability inferior, and a harmful gas (hydrogen chloride, sulfurous acid gas, and hydrogen sulfide).
- (4)The product shall be stored as tape packaging condition.

8.2 Term for use

- (1) The term for use is within one year from the shipping day of the product.
- (2) If the product has been left unused for more than one year after delivered, check solderability before use.

8.3 Chip mounting

- (1)When chip are mounted on the PC board, the protective coat of the product must not be scratched. If it will be scratched, it will make characteristic inferior.
- (2)In case that product will be soldered by soldering iron, heating shall be done on the land, and soldering iron must not hit on the product itself.
- (3)In case that resin coating or resin seal will be made for a PC board after chip mounting, do washing and drying it enough before coating or sealing. If ion bear or moisture will be sealed in resin coating, it will make characteristic inferior.
- (4)For resinous use, it is necessary to set up enough the curing conditions. As it gets improper for the condition, changes of a resistance value are large and are a case.
- (5)According to shape, material, and pressure of clamping in chip mounting machine, there is the case that crack will be appeared on the product.

Control a shock energy for clamping the product $under 7 \times 10^{-4}$ J.

- With a shock energy around clamping that says here, it is suited to a potential energy, in case that iron block of 25g is dropped naturally to the product placed on iron plate for the height of 2.8mm.
- (6)The glue to fix the product on the PC board around chip mounting, it is needed high insulation resistance and great performance or moisture. And it is needed that these characteristics are not inferior in using temperature range and a hot spot temperature to be acting.

8.4 Using and Handling

- (1)It is necessary to investigate the performance and reliability enough when using under harsh environment.
- (2)It is necessary to protect the edge and protective coat of the product from mechanical stress.
- (3)Handle with care when PC board is divided or fixed on support body, because bending of PC board after chip mounting will make mechanical stress for the product.
- (4)The product shall be used within rated range shown in specification.
 - Especially, if voltage more than specified value will be loaded to the product, there is a case it will make damage for machine because of temperature rise depending on generation of heat, and increase resistance value or breaks.
- (5)In case that product is loaded a rated voltage, it is necessary to confirm temperature of the product and to reduce a load power according to load reduction curve, because a temperature rise of the product depends on influence of heat from mounting density and neighboring element.
- (6)If there is a possibility that a large voltage (pulse voltage, shock voltage) charge to the product, It is necessary that operating condition shall be set up before use, because performance of the product is affected by a large shock voltage.
- (7) The items listed in the specifications assure the product quality as the product alone.
- Evaluation and confirmation of the product quality after mounting, in accordance with the operation condition, is required for actual use.

TITLE: RL1220□-※※※※-□ SPECIFICATION



SPEC.NO:

RL00-4053-E0